Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/841,505	CURRAN ET AL.
Examiner	Art Unit
Magid Y. Dimyan	2825

SEARCHED				
Class	Subclass	Date	Examiner	
716	18	4/19/2005	MYD	
716	6	4/19/2005	MYD	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
716	18,6	4/19/2005	MYD	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST; ALL DATABASES; IEEE XPLORE;	4/19/2005	MYD